


<b>Search Notes</b>  	<b>Application/Control No.</b>  10538202	<b>Applicant(s)/Patent Under Reexamination</b>  CHANG, CHIN
	<b>Examiner</b>  Abdi, Amara	<b>Art Unit</b>  2624

SEARCHED			
Class	Subclass	Date	Examiner
382	162	05/06/2008	Amara Abdi
345	83	05/06/2008	Amara Abdi
348	272	05/06/2008	Amara Abdi
430	30	05/06/2008	

SEARCH NOTES		
Search Notes	Date	Examiner
East: USPAT, US-PGPUB	05/06/2008	Amara Abdi
Google, E-Journal, IEEE explorer, STIC	05/06/2008	Amara Abdi
Consulted with the primary Chen Wenpeng	11/27/2007	Chen Wenpeng

INTERFERENCE SEARCH			
Class	Subclass	Date	Examiner